

FORM HDP-1449 (Based on Form PTO-1449)

ATTORNEY DOCKET NO.

SERIAL NO.

3174-000003

09/09/817,559

PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

APPLICANT

Peachee et al.

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FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation	
						Yes	No
33.	JS	WO 00/37731	29-06-00	WIPO		X	
34.	JS	GB 1200279	29-07-70	Great Britain		X	
35.	JS	09084282	28-03-97	Japan		X	
36.	JS	61030938	13-02-86	Japan		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	JS	G. Gallegos-Lopez, P.C. Kjaer, T.J.E. Miller, "A New Rotor Position Estimation Method For Switched Reluctance Motors Using PWM Voltage Control", in Proc EPE'97, 7th European Conf. on Power Electronics and Applications 8-10 Sept. 1997 Trondheim Norway Vol. 3 pp. 580-585.
2.	JS	Stephenson/Blake, "The Characteristics, Design and Applications of Switched Reluctance Motors and Drives", presented at the PCIM '93 Conference and Exhibition at Nuremburg, Germany, June 21-24, 1993.
3.	JS	T.J.E. Miller, "Switched Reluctance Motors and Their Control", Magna Physics Publishing and Clarendon Press Oxford 1993.
4.	JS	WF Ray and IH Al-Bahadly, "Sensorless Methods for Determining the Rotor Position of Switched Reluctance Motors", published in the Proceedings of the European Power Electronics Conference, Brighton UK 13-16 Sept. 1993 Vol. 6, pp. 7-13.

Examiner:

Johio Gonzalez

Date Considered:

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						Yes	No
13.	jj	11-289728	19-10-99	Japan		X	
14.	jj	11-289727	19-10-99	Japan		X	
15.	jj	11-289726	19-10-99	Japan		X	
16.	jj	11-289701	19-10-99	Japan		X	
17.	jj	11-275830	08-10-99	Japan		X	
18.	jj	10-271718	09-10-98	Japan		X	
19.	jj	09-233742	05-09-97	Japan		X	
20.	jj	2000-224790	11-08-00	Japan		X	
21.	jj	10-210721	07-08-98	Japan		X	
22.	jj	11-191987	13-07-99	Japan		X	
23.	jj	10-174319	26-06-98	Japan		X	
24.	jj	2000-139052	16-05-00	Japan		X	
25.	jj	11-089129	30-03-99	Japan		X	
26.	jj	05-038086	12-02-93	Japan		X	
27.	jj	2000-37050	02-02-00	Japan		X	
28.	jj	08-033292	02-02-96	Japan		X	
29.	jj	11-018331	22-01-99	Japan		X	
30.	jj	2000-014057	14-01-00	Japan		X	
31.	jj	2001-008395	12-01-01	Japan		X	
32.	jj	WO 00/79670A1	28-12-00	WIPO		X	

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U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
22.	jj	6,194,805	02/27/2001	Heese et al.		
23.	jj	6,266,591	06/24/2001	Wilson-Jones et al.		
24.	jj	6,329,782	12/11/2001	Chen et al.		
25.	jj	6,369,481	04/09/2002	Bahn		
26.	jj	6,373,211	04/16/2002	Henry et al.		

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Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	jj	EP0868010A1 21	30-09-98	Europe		X	
2.	jj	EP0823711A1 22	11-02-98	Europe		X	
3.	jj	EP0871282A1 23	14-10-98	Europe		X	
4.	jj	EP0778660A3 24	30-09-98	Europe		X	
5.	jj	EP0967135A2 25	29-12-99	Europe		X	
6.	jj	FR2719324 26	03-11-95	France		X	
7.	jj	EP0350429 27	10-01-90	Europe		X	
8.	jj	11-341717 28	10-12-99	Japan		X	
9.	jj	11-332138 29	30-11-99	Japan		X	
10.	jj	2000-333388 30	30-11-00	Japan		X	
11.	jj	09-322439 31	12-12-97	Japan		X	
12.	jj	2000-312451	07-11-00	Japan		X	

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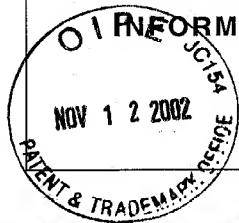
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Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	jj	2002/0089251A1	07/11/2002	Tajima et al.		
2.	jj	3,604,222	09/14/1971	Sandkrug et al.		
3.	jj	4,130,770	12/19/1978	Wrobel		
4.	jj	4,340,829	07/20/1982	McCoy		
5.	jj	4,698,542	10/06/1987	Muller		
6.	jj	4,772,839	09/20/1988	MacMinn et al.		
7.	jj	4,883,982	11/28/1989	Forbes et al.		
8.	jj	4,896,089	01/23/1990	Kliman et al.		
9.	jj	4,950,932	08/21/1990	Harms et al.		
10.	jj	4,959,596	09/25/1990	MacMinn et al.		
11.	jj	5,173,650	12/22/1992	Hedlund et al.		
12.	jj	5,257,828	11/02/1993	Miller et al.		
13.	jj	5,467,025	11/14/1995	Ray		
14.	jj	5,578,880	11/26/1996	Lyons et al.		
15.	jj	5,740,880	04/21/1998	Miller		
16.	jj	5,743,721	04/28/1998	Graham et al.		
17.	jj	5,786,651	07/28/1998	Suzuki		
18.	jj	5,806,169	09/15/1998	Trago et al.		
19.	jj	5,821,661	10/13/1998	Wissmach et al.		
20.	jj	5,877,568	03/02/1999	Maes et al.		
21.	jj	5,994,804	11/30/1999	Grennan et al.		

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